

# **CRMDTL138K** N-Channel 60V, 1.7Ω Typ. Power MOSFET

### Description

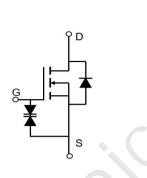
### **Features**

• 60V, 0.2A

 $R_{DS(ON)}$  Typ = 1.7 $\Omega$  @ V<sub>GS</sub> = 10V

 $R_{DS(ON)}$  Typ = 1.9 $\Omega$  @ V<sub>GS</sub> = 4.5V

- Advanced Trench Technology
- Excellent R<sub>DS(ON)</sub> and Low Gate Charge
- Lead Free
- ESD Protected: 2KV



Schematic Diagram

## Application

- Load Switch
- PWM Application
- Power Management

#### Marking and Pin Assignment

L138K

#### Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMDTL138K	L138K	DFN1006-3L	TAPING	7"	10000	400000

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#### Absolute Maximum Ratings (@ T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V <sub>DS</sub>	Drain-to-Source Voltage		60	V
V <sub>GS</sub>	Gate-to-Source Voltage		±20	V
	Continuous Drain Current		А	
Ι <sub>D</sub>		T <sub>A</sub> = 100°C	0.12	А
I <sub>DM</sub>	Pulsed Drain Current <sup>(1)</sup>		0.8	А
P <sub>D</sub>	Power Dissipation	T <sub>A</sub> = 25°C	0.15	W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Case $^{(2)}$		835	°C/W
Τ <sub>J</sub> , Τ <sub>stg</sub>	Junction & Storage Temperature Range		-55 to 150	°C



#### Electrical Characteristics (T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Chara	acteristics					
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	$I_{\rm D}$ = 250 $\mu$ A, V <sub>GS</sub> = 0V	60	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V	-	-	1.0	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±10	μΑ
On Chara	acteristics				6	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A	0.7	1.2	1.5	V
R <sub>DS(ON)</sub>	(3)	V <sub>GS</sub> = 10V, I <sub>D</sub> = 0.2A	-	1.7	2	Ω
	Static Drain-Source ON-Resistance <sup>(3)</sup>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 0.1A	-	1.9	2.3	Ω
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance		-	22	-	pF
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V, f = 1MHz	Χ-	3.4	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		$\mathbf{C}$	2.3	-	pF
Q <sub>g</sub>	Total Gate Charge	0	V.	1.6	-	nC
$Q_{gs}$	Gate Source Charge	$V_{GS} = 0 \text{ to } 4.5V$ $V_{DS} = 10V, I_D = 0.2A$	) -	0.2	-	nC
$Q_{gd}$	Gate Drain("Miller") Charge	$v_{\rm DS} = 100, n_{\rm D} = 0.2A$	-	0.5	-	nC
Switchin	g Characteristics					
t <sub>d(on)</sub>	Turn-On DelayTime		-	2	-	ns
t <sub>r</sub>	Turn-On Rise Time	V <sub>GS</sub> = 10V, V <sub>DD</sub> = 10V	-	14	-	ns
$t_{d(off)}$	Turn-Off DelayTime	$I_{D}$ = 0.2A, $R_{GEN}$ = 10 $\Omega$	-	6	-	ns
t <sub>f</sub>	Turn-Off Fall Time		-	19	-	ns
Drain-So	urce Diode Characteristics and N	lax Ratings				
I <sub>S</sub>	Maximum Continuous Drain to Source Die	-	-	0.2	А	
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	0.8	А
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 0.2A	-	-	1.2	V
Notes:	1. Repetitive Rating: Pulse Width Limited by Maxim	um Junction Temperature.				

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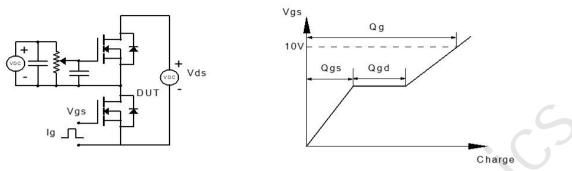
2.  $R_{\theta JA}$  is measured with the device mounted on a 1inch<sup>2</sup> pad of 2oz copper FR4 PCB

3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.



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### **Test Circuit**





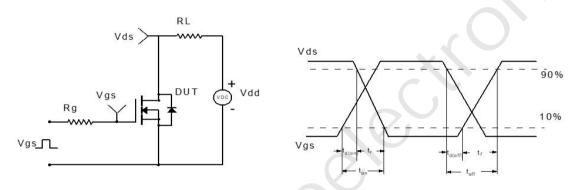


Figure 2: Resistive Switching Test Circuit & Waveform

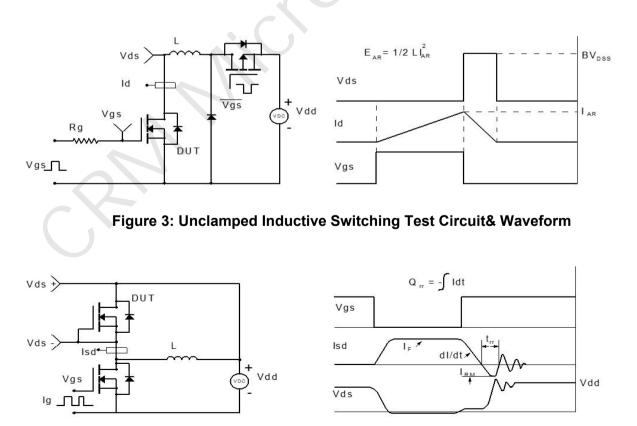
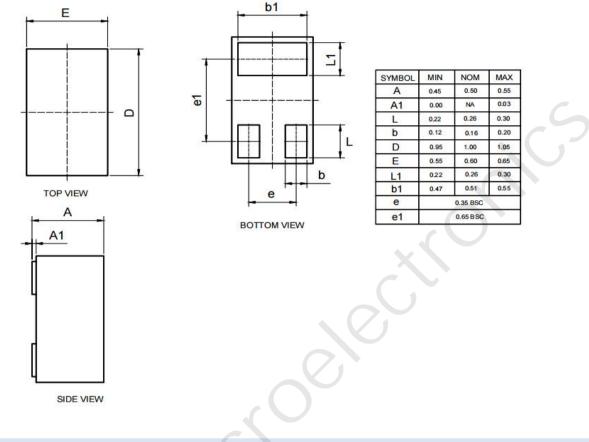


Figure 4: Diode Recovery Test Circuit & Waveform



## Package Mechanical Data(DFN1006-3L)



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